

Search Notes

Application/Control No.

10/731,524

Examiner

Mathieu D. Vargot

Applicant(s)/Patent under
Reexamination

HASEGAWA ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	1.1, 1.34, 185, 216, 211.12		
359	490	4/7/06	410V

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR